

Three Level NPC Q2Pack Module

NXH400N100L4Q2F2SG, NXH400N100L4Q2F2PG

The NXH400N100L4Q2 is a power module containing a I- type neutral point clamped three-level inverter. The integrated field stop trench IGBTs and FRDs provide lower conduction losses and switching losses, enabling designers to achieve high efficiency and superior reliability.

Features

- Neutral Point Clamped Three-level Inverter Module
- Extreme Efficient Trench with Field Stop Technology
- Low Inductive Layout
- Low Package Height
- Thermistor

Typical Applications

- Solar Inverters
- Energy Storage System
- Uninterruptable Power Supplies Systems

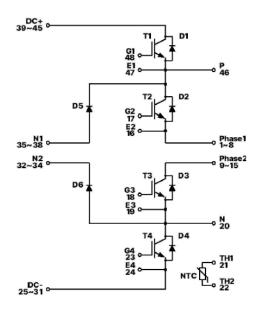
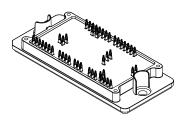
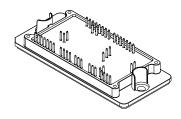


Figure 1. NXH400N100L4Q2F2 Schematic Diagram

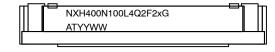


Q2PACK PRESS FIT PINS PIM48, 93x47 CASE 180CR



Q2PACK SOLDER PINS PIM48, 93x47 CASE 180BL

MARKING DIAGRAM

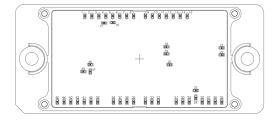


NXH400N100L4Q2F2xG = Specific Device Code

= P or S G

= Pb-Free Package ΑT = Assembly & Test Site Code YYWW = Year and Work Week Code

PIN CONNECTIONS



ORDERING INFORMATION

See detailed ordering and shipping information on page 5 of this data sheet.

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Table 1. ABSOLUTE MAXIMUM RATINGS (T_J = 25°C unless otherwise noted) (Note 1)

Rating	Symbol	Value	Unit
GBT (T1, T2, T3, T4)	1		•
Collector-Emitter Voltage	V _{CES}	1000	V
Gate-Emitter Voltage Positive Transient Gate-Emitter Voltage (T_{pulse} = 5 μ s, D < 0.10)	V _{GE}	±20 30	V
Continuous Collector Current @ T _C = 80°C	I _C	360	А
Pulsed Peak Collector Current @ T _C = 80°C (T _J = 175°C)	I _{C(Pulse)}	1080	А
Maximum Power Dissipation (T _J = 175°C)	P _{tot}	980	W
Minimum Operating Junction Temperature	T _{JMIN}	-40	°C
Maximum Operating Junction Temperature (Note 2)	T _{JMAX}	175	°C
GBT INVERSE DIODE (D1, D2, D3, D4)			
Peak Repetitive Reverse Voltage	V_{RRM}	1000	V
Continuous Forward Current @ T _C = 80°C	I _F	276	А
Repetitive Peak Forward Current (T _J = 175°C)	I _{FRM}	828	А
Maximum Power Dissipation (T _J = 175°C)	P _{tot}	680	W
Minimum Operating Junction Temperature	T _{JMIN}	-40	°C
Maximum Operating Junction Temperature	T _{JMAX}	175	°C
IEUTRAL POINT DIODE (D5, D6)			
Peak Repetitive Reverse Voltage	V_{RRM}	1000	V
Continuous Forward Current @ T _C = 80°C	I _F	291	А
Repetitive Peak Forward Current (T _J = 175°C)	I _{FRM}	873	А
Maximum Power Dissipation (T _J = 175°C)	P _{tot}	734	W
Minimum Operating Junction Temperature	T _{JMIN}	-40	°C
Maximum Operating Junction Temperature	T _{JMAX}	175	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

Table 2. THERMAL AND INSULATION PROPERTIES (T_J = 25°C unless otherwise noted) (Note 1)

Rating	Symbol	Value	Unit
THERMAL PROPERTIES			
Operating Temperature under Switching Condition	T_{VJOP}	-40 to 150	°C
Storage Temperature Range	T _{stg}	-40 to 125	°C
INSULATION PROPERTIES			
Isolation Test Voltage, t = 1 s, 50 Hz (Note 2)	V _{is}	4000	V_{RMS}
Creepage Distance		12.7	mm
Comparative Tracking Index	CTI	>600	

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

Refer to <u>ELECTRICAL CHARACTERISTICS</u>, RECOMMENDED OPERATING RANGES and/or APPLICATION INFORMATION for Safe Operating parameters.

^{2. 4000} VAC_{RMS} for 1 second duration is equivalent to 3333 VAC_{RMS} for 1 minute duration.

ELECTRICAL CHARACTERISTICS (T_{.I} = 25°C unless otherwise noted)

Characteristic	Symbol	Test Conditions	Min	Тур	Max	Unit
OUTER IGBT (T1, T4) CHARACTERISTI	cs					
Collector-Emitter Cutoff Current	I _{CES}	V _{GE} = 0 V, V _{CE} = 1000 V	-	-	25	μА
Collector-Emitter Saturation Voltage	V _{CE(sat)}	V _{GE} = 15 V, I _C = 400 A, T _J = 25°C	_	1.65	2.2	V
		V _{GE} = 15 V, I _C = 400 A, T _J = 150°C	-	1.9	-	1
Gate-Emitter Threshold Voltage	V _{GE(TH)}	V _{GE} = V _{CE} , I _C = 400 mA	3.6	4.9	6.2	٧
Gate Leakage Current	I _{GES}	V _{GE} = ±20 V, V _{CE} = 0 V	-	=	±1.0	μА
Turn-on Delay Time	t _{d(on)}	T _J = 25°C	-	170.46	-	ns
Rise Time	t _r	$V_{CE} = 600 \text{ V}, I_{C} = 200 \text{ A}$ $V_{GE} = -9 \text{ V}, 15 \text{ V},$	_	54.38	=	1
Turn-off Delay Time	t _{d(off)}	$R_{Gon} = 9 \Omega$, $R_{Goff} = 19 \Omega$	_	696.63	=	1
Fall Time	t _f	1	_	12.91	-	1
Turn-on Switching Loss per Pulse	E _{on}	1	_	8.96	_	mJ
Turn-off Switching Loss per Pulse	E _{off}	1	_	6	-	1
Turn-on Delay Time	t _{d(on)}	T _J = 125°C	_	163.09	_	ns
Rise Time	t _r	$V_{CE} = 600 \text{ V}, I_{C} = 200 \text{ A}$ $V_{GE} = -9 \text{ V}, 15 \text{ V},$	_	61.38		1
Turn-off Delay Time	t _{d(off)}	$R_{Gon} = 9 \Omega$, $R_{Goff} = 19 \Omega$	-	771.31	-	1
Fall Time	t _f	1	-	18.23	-	1
Turn-on Switching Loss per Pulse	E _{on}	1	_	14.54		mJ
Turn-off Switching Loss per Pulse	E _{off}	1	-	9.8	-	1
Input Capacitance	C _{ies}	V _{CE} = 20 V, V _{GE} = 0 V, f = 1 MHz	-	26060	-	pF
Output Capacitance	C _{oes}	1	-	1182	-	
Reverse Transfer Capacitance	C _{res}	1	=	146	=]
Total Gate Charge	Q_g	$V_{CE} = 600 \text{ V}, I_{C} = 300 \text{ A},$ $V_{GE} = -15 \text{ V} \sim 15 \text{ V}$	=	1410	=	nC
Thermal Resistance - Chip-to-Heatsink	R _{thJH}	Thermal grease,	_	0.17	_	K/W
Thermal Resistance - Chip-to-Case	R _{thJC}	Thickness = 100 μm ±2% λ = 2.9 W/mK	_	0.0969	_	K/W
NEUTRAL POINT DIODE (D5, D6) CHAF	ACTERISTIC	cs	ı			
Diode Forward Voltage	V _F	I _F = 225 A, T _{.I} = 25°C	_	2.1	2.7	V
-		I _F = 225 A, T _J = 150°C	_	1.9	_	1
Reverse Recovery Time	t _{rr}	T _J = 25°C	_	91.65	_	ns
Reverse Recovery Charge	Q _{rr}	$V_{CE} = 600 \text{ V, } I_{C} = 200 \text{ A}$ $V_{GE} = -9 \text{ V, } 15 \text{ V, } R_{G} = 9 \Omega$	_	5109	ī	nC
Peak Reverse Recovery Current	I _{RRM}	VGE - 0 V, 10 V, 11G - 0 12	_	117.19	-	Α
Peak Rate of Fall of Recovery Current	di/dt		_	3.02	-	A/ns
Reverse Recovery Energy	E _{rr}	1	_	1504	_	μJ
Reverse Recovery Time	t _{rr}	T _J = 125°C	_	168.8	ï	ns
Reverse Recovery Charge	Q _{rr}	$V_{CE} = 600 \text{ V, } I_{C} = 200 \text{ A}$ $V_{GE} = -9 \text{ V, } 15 \text{ V, } R_{G} = 9 \Omega$	_	15979	-	nC
Peak Reverse Recovery Current	I _{RRM}	- GE 5 1, 10 1, 11G - 0 11	-	183.14	-	Α
Peak Rate of Fall of Recovery Current	di/dt		_	2.64	=	A/ns
Reverse Recovery Energy	E _{rr}	†	_	5463	_	μJ
Thermal Resistance - Chip-to-Heatsink	R _{thJH}	Thermal grease,	_	0.21	_	K/W
Thermal Resistance – Chip-to-Case	R _{thJC}	Thickness = 100 μ m \pm 2% λ = 2.9 W/mK	_	0.1295	_	K/W

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted) (continued)

Characteristic	Symbol	Test Conditions	Min	Тур	Max	Unit
INNER IGBT (T2, T3) CHARACTERISTIC	s					
Collector-Emitter Cutoff Current	I _{CES}	V _{GE} = 0 V, V _{CE} = 1000 V	=	-	25	μΑ
Collector-Emitter Saturation Voltage	V _{CE(sat)}	V_{GE} = 15 V, I_{C} = 400 A, T_{J} = 25 °C	1	1.65	2.2	V
		V _{GE} = 15 V, I _C = 400 A, T _J = 150 °C	1	1.9	1	
Gate-Emitter Threshold Voltage	V _{GE(TH)}	V _{GE} = V _{CE} , I _C = 400mA	3.9	4.6	5.8	V
Gate Leakage Current	I _{GES}	$V_{GE} = \pm 20 \text{ V}, V_{CE} = 0 \text{ V}$	1	_	±1.0	μΑ
Turn-on Delay Time	t _{d(on)}	$T_J = 25^{\circ}C$ $V_{CE} = 600 \text{ V}, I_C = 200 \text{ A},$	-	171.27	1	ns
Rise Time	t _r	$V_{CE} = 600 \text{ V}, I_{C} = 200 \text{ A},$ $V_{GE} = -9 \text{ V}, 15 \text{ V},$	-	52.54	-	
Turn-off Delay Time	t _{d(off)}	$R_{Gon} = 9 \Omega, R_{Goff} = 28 \Omega$	_	1153.7	=	
Fall Time	t _f]	_	34.88	_	
Turn-on Switching Loss per Pulse	E _{on}]	=	8.16	=	mJ
Turn off Switching Loss per Pulse	E _{off}		_	10.25		
Turn-on Delay Time	t _{d(on)}	$T_J = 125^{\circ}C$ $V_{CE} = 600 \text{ V, } I_C = 200 \text{ A,}$	=	160.21	=	ns
Rise Time	t _r	V _{GE} = -9 V, 15 V,	-	59.83	-	
Turn-off Delay Time	t _{d(off)}	$R_{Gon} = 9 \Omega, R_{Goff} = 28 \Omega$	_	1274.8	_	
Fall Time	t _f	1	-	26.46	-	
Turn-on Switching Loss per Pulse	E _{on}	1	_	12.37	_	mJ
Turn off Switching Loss per Pulse	E _{off}		-	13.42	-	
Input Capacitance	C _{ies}	$V_{CE} = 20 \text{ V}, V_{GE} = 0 \text{ V}, f = 1 \text{ MHz}$	_	26060	_	pF
Output Capacitance	C _{oes}	1	_	1182	_	4
Reverse Transfer Capacitance	C _{res}		_	146	_	
Total Gate Charge	Q_g	$V_{CE} = 600 \text{ V}, I_{C} = 300 \text{ A},$ $V_{GE} = -15 \text{ V} \sim 15 \text{ V}$	-	1410	_	nC
Thermal Resistance - Chip-to-heatsink	R_{thJH}	Thermal grease, Thickness = 100 μm ±2%	1	0.17	1	K/W
Thermal Resistance - Chip-to-case	R_{thJC}	$\lambda = 2.9 \text{ W/mK}$		0.0969	ı	K/W
IGBT INVERSE DIODE (D1, D2, D3, D4)	CHARACTE	RISTICS				
Diode Forward Voltage	V _F	I _F = 225 A, T _J = 25°C	-	2.1	2.7	V
		I _F = 225 A, T _J = 150°C	-	1.9	-	
Reverse Recovery Time	t _{rr}	T _J = 25°C	=	90.31	=	ns
Reverse Recovery Charge	Q _{rr}	V_{CE} = 600 V, I_{C} = 200 A V_{GE} = -9 V, 15 V, R_{G} = 9 Ω	ı	5653	ı	nC
Peak Reverse Recovery Current	I _{RRM}		1	123.4	1	Α
Peak Rate of Fall of Recovery Current	di/dt		=	3.178	=	A/ns
Reverse Recovery Energy	E _{rr}	1	_	1860	_	μJ
Reverse Recovery Time	t _{rr}	T _J = 125°C	=	167.18	=	ns
Reverse Recovery Charge	Q _{rr}	$V_{CE} = 600 \text{ V}, I_{C} = 200 \text{ A}$ $V_{GF} = -9 \text{ V}, 15 \text{ V}, R_{G} = 9 \Omega$	-	16627	-	nC
Peak Reverse Recovery Current	I _{RRM}	- GE - 1, 11 1, 1 1 G - 1	-	182.8	-	Α
Peak Rate of Fall of Recovery Current	di/dt		-	2.734	_	A/ns
Reverse Recovery Energy	E _{rr}	1	=	6512	_	μJ
Thermal Resistance - Chip-to-Heatsink	R _{thJH}	Thermal grease,	_	0.22	_	K/W
Thermal Resistance - Chip-to-Case	R _{thJC}	Thickness = 100 μ m $\pm 2\%$ λ = 2.9 W/mK	=	0.1397	=	K/W
THERMISTOR CHARACTERISTICS						
Nominal Resistance	R ₂₅	T = 25°C	-	5	_	kΩ
Nominal Resistance	R ₁₀₀	T = 100°C	-	490.6	-	Ω

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted) (continued)

Characteristic	Symbol	Test Conditions	Min	Тур	Max	Unit
THERMISTOR CHARACTERISTICS			<u>.</u>			
Deviation of R25	ΔR/R		-1	-	1	%
Power Dissipation	P _D		-	5	-	mW
Power Dissipation Constant			-	1.3	-	mW/K
B-value		B (25/85), tolerance ±1%	-	3435	-	K

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

ORDERING INFORMATION

Part Number	Marking	Package	Shipping
NXH400N100L4Q2F2PG	NXH400N100L4Q2F2PG	Q2PACK PRESS FIT PINS PIM48, 93x47 (Pb-Free and Halide-Free)	12 Units / Blister Tray
NXH400N100L4Q2F2SG	NXH400N100L4Q2F2SG	Q2PACK SOLDER PIN PIM48, 93x47 (Pb-Free and Halide-Free)	12 Units / Blister Tray

TYPICAL CHARACTERISTICS - IGBT, INVERSE DIODE AND NEUTRAL POINT DIODE

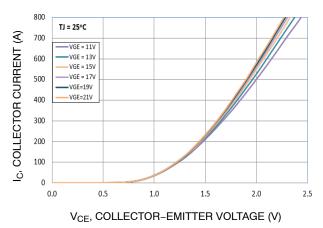


Figure 2. Typical Output Characteristics - IGBT

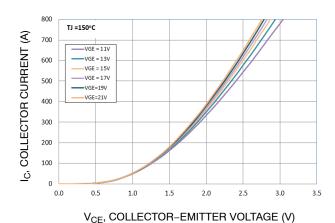


Figure 3. Typical Output Characteristics - IGBT

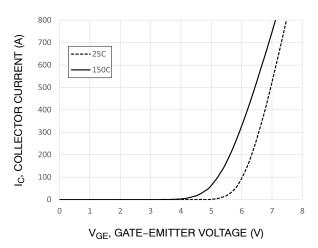


Figure 4. Transfer Characteristics - IGBT

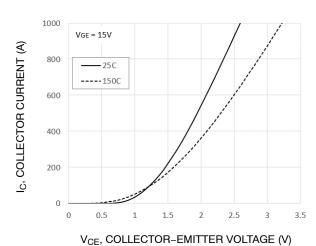


Figure 5. Saturation Voltage Characteristics

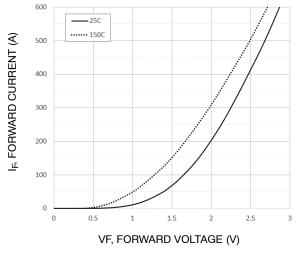


Figure 6. Inverse Diode Forward Characteristics

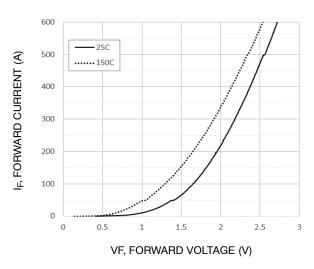


Figure 7. Buck Diode Forward Characteristics

TYPICAL CHARACTERISTICS - OUTER IGBT (T1, T4)

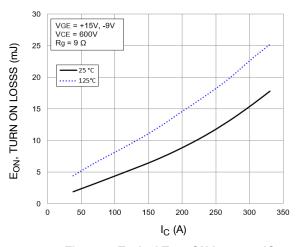


Figure 8. Typical Turn ON Loss vs. IC

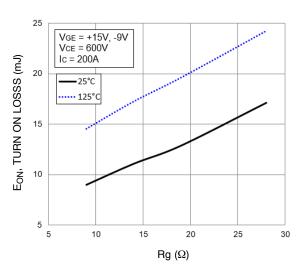


Figure 10. Typical Turn ON Loss vs. RG

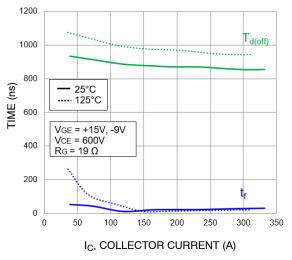


Figure 12. Typical Turn-Off Switching Time vs. IC

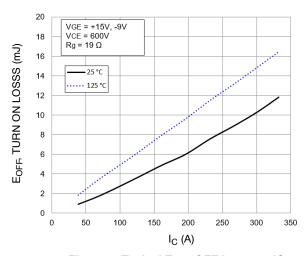


Figure 9. Typical Turn OFF Loss vs. IC

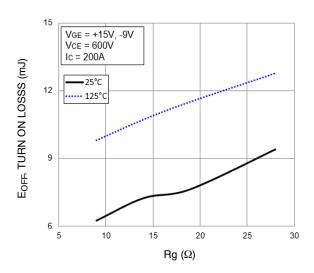


Figure 11. Typical Turn OFF Loss vs. RG

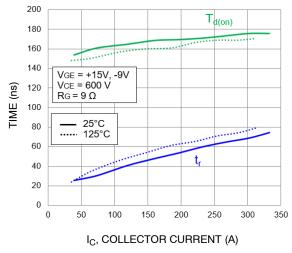


Figure 13. Typical Turn-On Switching Time vs. IC

TYPICAL CHARACTERISTICS - OUTER IGBT (T1,T4) (continued)

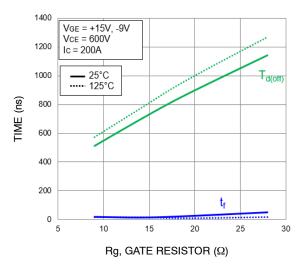


Figure 14. Typical Turn-Off Switching Time vs. RG

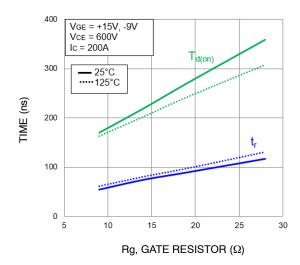


Figure 15. Typical Turn-On Switching Time vs. RG

TYPICAL CHARACTERISTICS - INNER IGBT (T2, T3)

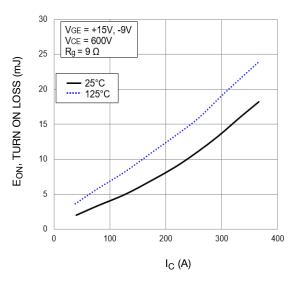


Figure 16. Typical Turn ON Loss vs. IC

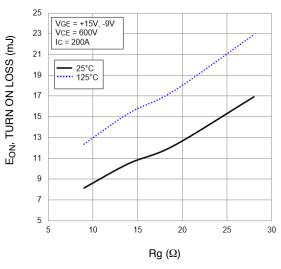


Figure 18. Typical Turn ON Loss vs. RG

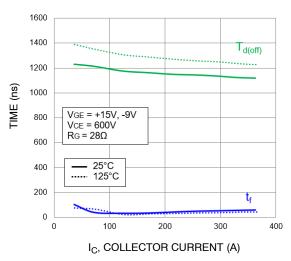


Figure 20. Typical Turn-Off Switching Time vs. IC

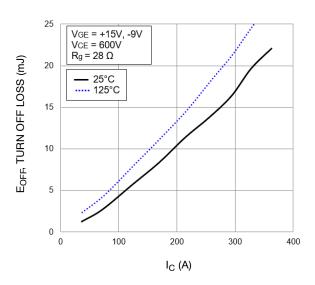


Figure 17. Typical Turn OFF Loss vs. IC

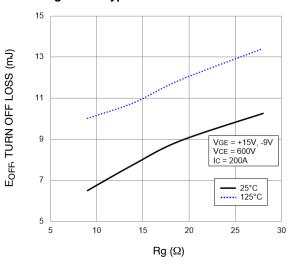


Figure 19. Typical Turn OFF Loss vs. RG

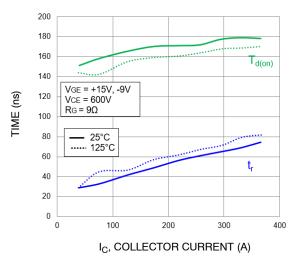
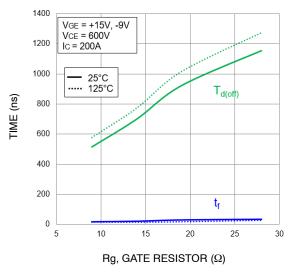


Figure 21. Typical Turn-On Switching Time vs. IC

TYPICAL CHARACTERISTICS - INNER IGBT (T2, T3) (continued)



WILE 200

VGE = +15V, -9V
VCE = 600V
IC = 200A

T_{d(on)}

T_{tr}

100

Fg, GATE RESISTOR (Ω)

Figure 22. Typical Turn-Off Switching Time vs. RG

Figure 23. Typical Turn-On Switching Time vs. RG

TYPICAL SWITCHING CHARACTERISTICS - NEUTRAL POINT DIODE

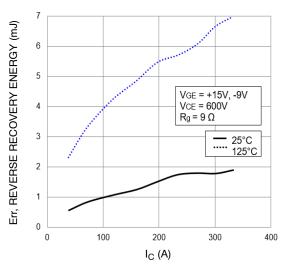


Figure 24. Typical Reverse Recovery Energy Loss vs. IC

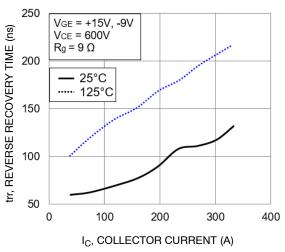


Figure 26. Typical Reverse Recovery Time vs. IC

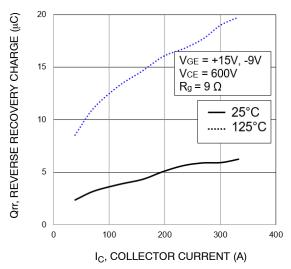


Figure 28. Typical Reverse Recovery Charge vs. IC

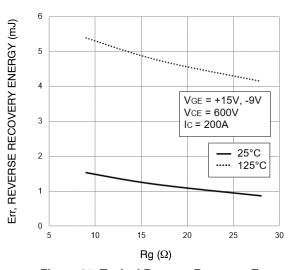


Figure 25. Typical Reverse Recovery Energy Loss vs. Rg

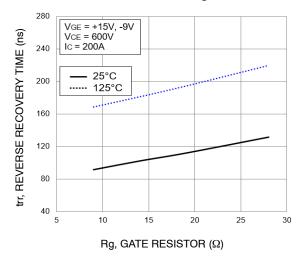


Figure 27. Typical Reverse Recovery Time vs. Rg

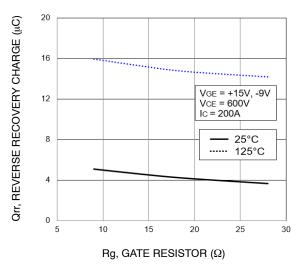


Figure 29. Typical Reverse Recovery Charge vs. Rg

TYPICAL SWITCHING CHARACTERISTICS - NEUTRAL POINT DIODE (continued)

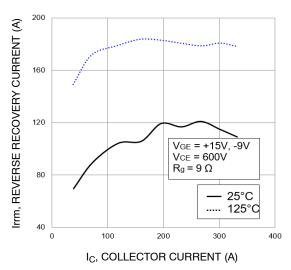


Figure 30. Typical Reverse Recovery Peak Current vs. IC

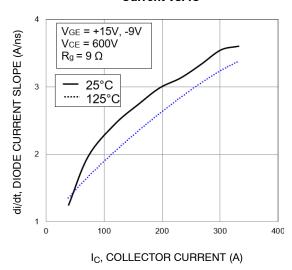


Figure 32. Typical di/dt vs. IC

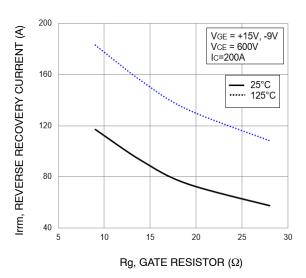


Figure 31. Typical Reverse Recovery Peak
Current vs. Rg

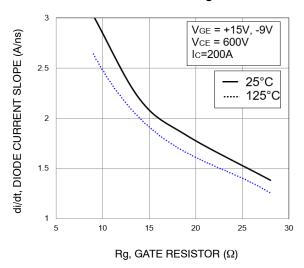


Figure 33. Typical di/dt vs. Rg

TYPICAL CHARACTERISTICS - INVERSE DIODE

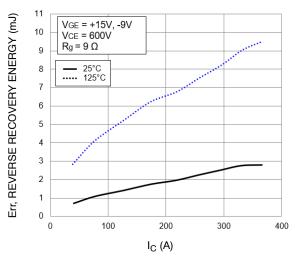


Figure 34. Typical Reverse Recovery Energy Loss vs. IC

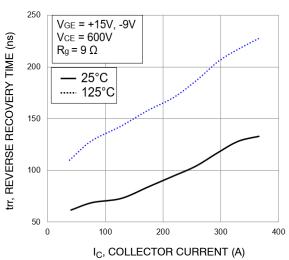


Figure 36. Typical Reverse Recovery Time vs. IC

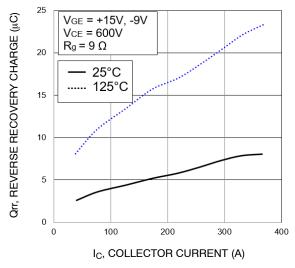


Figure 38. Typical Reverse Recovery Charge vs. IC

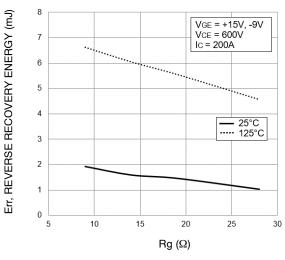


Figure 35. Typical Reverse Recovery Energy Loss vs. Rg

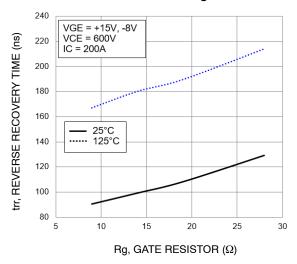


Figure 37. Typical Reverse Recovery Time vs. Rg

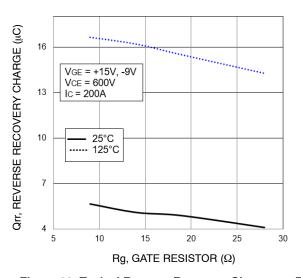


Figure 39. Typical Reverse Recovery Charge vs. Rg

TYPICAL CHARACTERISTICS - INVERSE DIODE (continued)

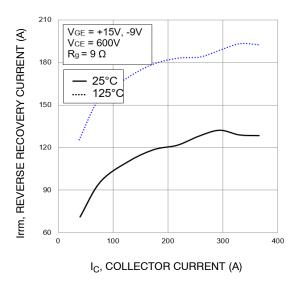


Figure 40. Typical Reverse Recovery Peak Current vs. IC

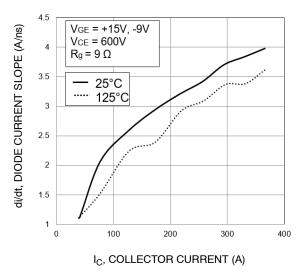


Figure 42. Typical di/dt vs. IC

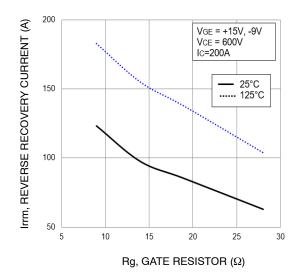


Figure 41. Typical Reverse Recovery Peak Current vs. Rg

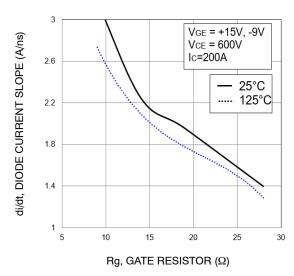
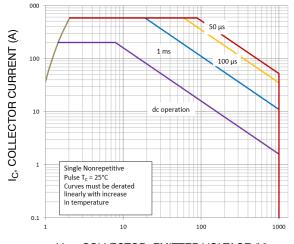


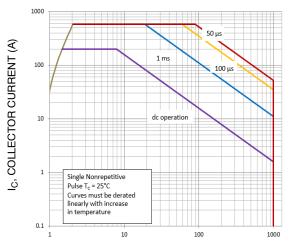
Figure 43. Typical di/dt vs. Rg

TYPICAL CHARACTERISTICS - IGBT, INVERSE DIODE AND NEUTRAL POINT DIODE



 V_{CE} , COLLECTOR-EMITTER VOLTAGE (V)

Figure 44. FBSOA - Outer IGBT



V_{CE}, COLLECTOR-EMITTER VOLTAGE (V)

Figure 46. FBSOA - Inner IGBT

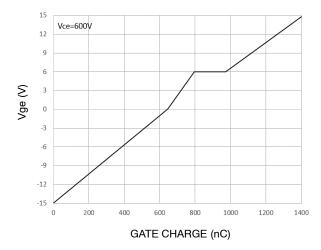


Figure 48. Gate Voltage vs. Gate Charge

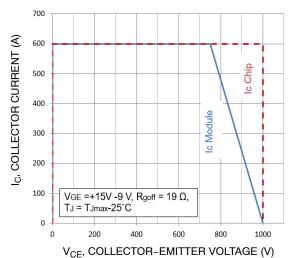
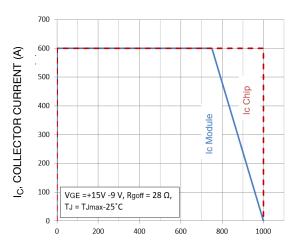
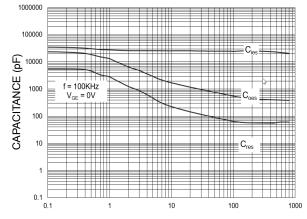


Figure 45. RBSOA – Outer IGBT



V_{CE}, COLLECTOR-EMITTER VOLTAGE (V)

Figure 47. RBSOA – Inner IGBT



V_{CE}, COLLECTOR TO EMITTER VOLTAGE (V)

Figure 49. Capacitance Charge

TYPICAL CHARACTERISTICS - IGBT, INVERSE DIODE AND NEUTRAL POINT DIODE (continued)

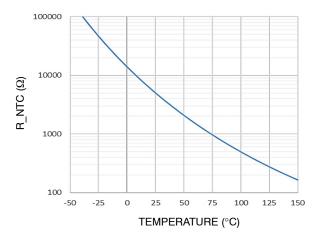


Figure 50. Thermistor Characteristics

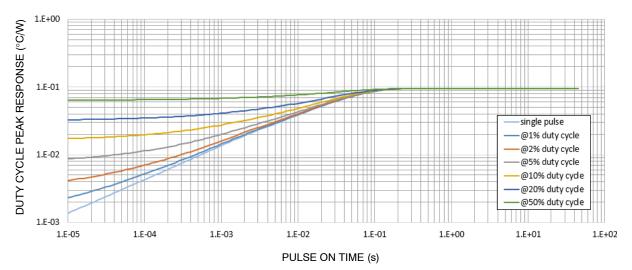


Figure 51. Transient Thermal Impedance - IGBT

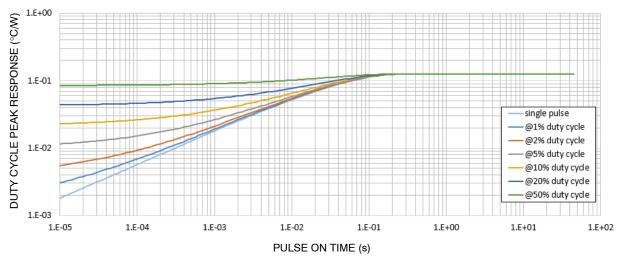


Figure 52. Transient Thermal Impedance - Inverse Diode

TYPICAL CHARACTERISTICS - IGBT, INVERSE DIODE AND NEUTRAL POINT DIODE (continued)

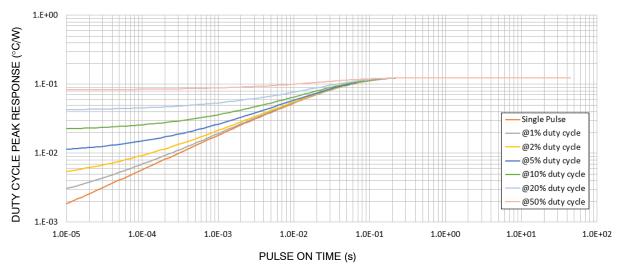
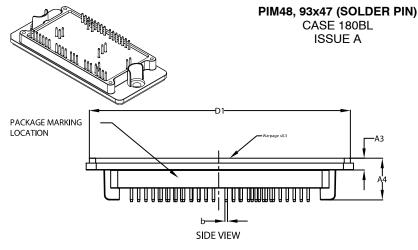


Figure 53. Transient Thermal Impedance – Neutral Point Diode

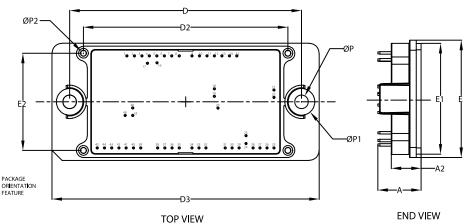






DATE 08 DEC 2022

- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 2009
- 2. CONTROLLING DIMENSION: MILLIMETERS
- 3. DIMENSIONS b AND b1 APPLY TO THE PLATED TERMINALS AND ARE MEASURED AT DIMENSION A1
- 4. PIN POSITION TOLERANCE IS \pm 0.4mm
- 5. PACKAGE MARKING IS LOCATED AS SHOWN ON THE SIDE OPPOSITE THE PACKAGE ORIENTATION FEATURES



MILLIMETERS					
MIN.	NOM.	MAX.			
16.80	17.20	17.60			
11.70	12.00	12.30			
4.40	4.70	5.00			
16.40	16.70	17.00			
0.95	1.00	1.05			
92.90	93.00	93.10			
104.45	104.75	105.05			
81.80	82.00	82.20			
106.90	107.20	107.50			
46.70	47.00	47.30			
44.10	44.40	44.70			
38.80	39.00	39.20			
5.40	5.50	5.60			
10.60	10.70	10.80			
1.80	2.00	2.20			
	MIN. 16.80 11.70 4.40 16.40 0.95 92.90 104.45 81.80 106.90 46.70 44.10 38.80 5.40	MIN. NOM. 16.80 17.20 11.70 12.00 4.40 4.70 16.40 16.70 0.95 1.00 92.90 93.00 104.45 104.75 81.80 82.00 106.90 107.20 46.70 47.00 44.10 44.40 38.80 39.00 5.40 5.50 10.60 10.70			

S Pin position

Pin table			Pin table				
Pin	х	Υ	Function	Pin	х	Υ	Function
1	11.9	36.9	Phase1	25	70.9	0	DC-
2	14.9	36.9	Phase1	26	68.1	0	DC-
3	17.9	36.9	Phase1	27	65.3	0	DC-
4	20.9	36.9	Phase1	28	62.5	0	DC-
5	23.9	36.9	Phase1	29	56.9	0	DC-
6	26.9	36.9	Phase1	30	54.1	0	DC-
7	29.9	36.9	Phase1	31	51.3	0	DC-
8	32.9	36.9	Phase1	32	43.6	0	N2
9	38	36.9	Phase2	33	40.8	0	N2
10	41	36.9	Phase2	34	38	0	N2
11	44	36.9	Phase2	35	32.9	0	N1
12	47	36.9	Phase2	36	30	0	N1
13	50	36.9	Phase2	37	27.1	0	N1
14	53	36.9	Phase2	38	24.2	0	N1
15	56	36.9	Phase2	39	17.4	0	DC+
16	23.95	34.1	E2	40	14.5	0	DC+
17	20.15	33.9	G2	41	11.6	0	DC+
18	47	23.65	G3	42	8.7	0	DC+
19	47	20.65	E3	43	5.8	0	DC+
20	48.4	15.95	N	44	2.9	0	DC+
21	70.9	23.2	TH1	45	0	0	DC+
22	70.9	20.2	TH2	46	14.2	16	Р
23	59.7	4.85	G4	47	14.2	13	E1
24	59.7	1.75	F4	48	11.2	13	61

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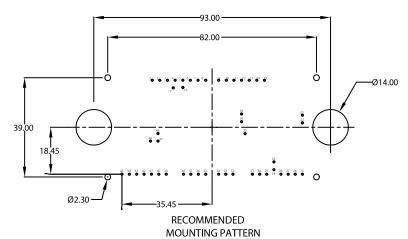
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PIM48, 93x47 (SOLDER PIN)

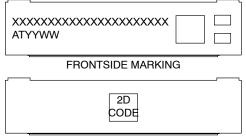
CASE 180BL ISSUE A

DATE 08 DEC 2022



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GENERIC MARKING DIAGRAM*



BACKSIDE MARKING

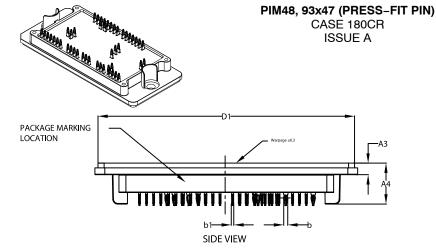
XXXXX = Specific Device Code
AT = Assembly & Test Site Code
YYWW = Year and Work Week Code

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "•", may or may not be present. Some products may not follow the Generic Marking.

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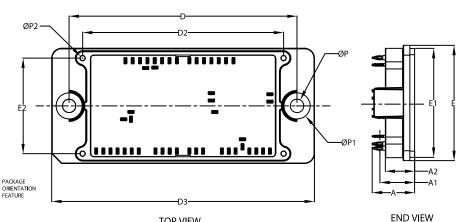






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	MILLIMETERS				
DIM	MIN.	NOM.	MAX.		
Α	16.90	17.30	17.70		
A1	13.97	14.18	14.39		
A2	11.70	12.00	12.30		
A3	4.40	4.70	5.00		
A4	16.40	16.70	17.00		
b	1.61	1.66	1.71		
b1	0.75	0.80	0.85		
D	92.90	93.00	93.10		
D1	104.45	104.75	105.05		
D2	81.80	82.00	82.20		
D3	106.90	107.20	107.50		
E	46.70	47.00	47.30		
E1	44.10	44.40	44.70		
E2	38.80	39.00	39.20		
Р	5.40	5.50	5.60		
P1	10.60	10.70	10.80		
P2	1.80	2.00	2.20		

Pin position

TOP VIEW

Pin table			Pin table				
Pin	х	Υ	Function	Pin	Х	Y	Function
1	11.9	36.9	Phase1	25	70.9	0	DC-
2	14.9	36.9	Phase1	26	68.1	0	DC-
3	17.9	36.9	Phase1	27	65.3	0	DC-
4	20.9	36.9	Phase1	28	62.5	0	DC-
5	23.9	36.9	Phase1	29	56.9	0	DC-
6	26.9	36.9	Phase1	30	54.1	0	DC-
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9	38	36.9	Phase2	33	40.8	0	N2
10	41	36.9	Phase2	34	38	0	N2
11	44	36.9	Phase2	35	32.9	0	N1
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17	20.15	33.9	G2	41	11.6	0	DC+
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20	48.4	15.95	N	44	2.9	0	DC+
21	70.9	23.2	TH1	45	0	0	DC+
22	70.9	20.2	TH2	46	14.2	16	Р
23	59.7	4.85	G4	47	14.2	13	E1
24	59.7	1.75	E4	48	11.2	13	G1

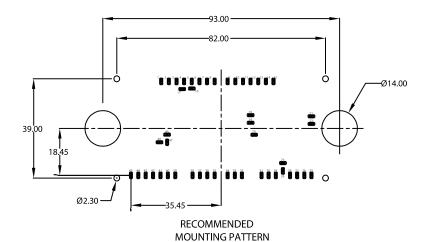
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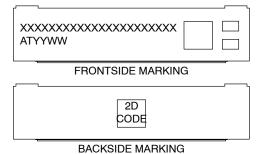
PIM48, 93x47 (PRESS-FIT PIN) CASE 180CR ISSUE A

DATE 08 DEC 2022



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GENERIC MARKING DIAGRAM*



XXXXX = Specific Device Code
AT = Assembly & Test Site Code
YYWW = Year and Work Week Code

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "•", may or may not be present. Some products may not follow the Generic Marking.

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